

<b>Notice of References Cited</b>	Application/Control No. 10/691,119		Applicant(s)/Patent Under Reexamination SEWARD ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0067197	04-2004	Leclerc et al.	424/001.73
*	B	US-2003/0120297	06-2003	Beyerlein, Dagmar Bettina	606/185
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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